imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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<u>.</u>	AOTF3N80 800V, 2.8A N-Channel MOSFET			
	Product Summary			
an advanced gned to deliver in popular AC- C_{iss} and C_{rss} y this part can ffline power	V_{DS} I _D (at V _{GS} =10V) R _{DS(ON)} (at V _{GS} =10V)	900V@150℃ 2.8A < 4.8Ω		
nber:	100% UIS Tested 100% Rg Tested			
	o— G			
ss otherwise n	oted	05		
ess otherwise n Symbol	oted AOTF3N80	Units		
Symbol		0 S Units V		
Symbol V _{DS}	AOTF3N80			
Symbol	AOTF3N80 800	V		
Symbol V _{DS} V _{GS}	AOTF3N80 800 ±30 2.8* 1.8* 9	V V V		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR}	AOTF3N80 800 ±30 2.8* 1.8*	V V V		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR}	AOTF3N80 800 ±30 2.8* 1.8* 9	V V A		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR}	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145	V V A A		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR}	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145 5	V V A A MJ MJ V/ns		
Symbol V _{DS} V _{GS} ID I _{DM} I _{AR} E _{AR} E _{AS}	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145	V V A A MJ mJ mJ		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145 5 35	V V A MJ W		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dV/dt P _D	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145 5 35 0.3	V V A A MJ MJ V/ns V/ns W W/ °C		
$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & \\ \hline V_{GS} & & \\ \hline & I_D & & \\ \hline & I_{DM} & & \\ \hline & I_{AR} & & \\ \hline & E_{AR} & & \\ \hline & E_{AS} & & \\ \hline & dv/dt & & \\ \hline & P_D & & \\ \hline & T_J, T_{STG} & \\ \hline & T_L & & \\ \hline \end{tabular}$	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145 5 35 0.3 -55 to 150 300	V V A A MJ MJ V/ns V/ns W W/ °C °C °C		
Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} dv/dt P _D T _J , T _{STG}	AOTF3N80 800 ±30 2.8* 1.8* 9 2.2 72 145 5 35 0.3 -55 to 150	V V A A MJ MJ V/ns V/ns W W/ °C °C		
	an advanced gned to deliver in popular AC- c _{iss} and C _{rss} y this part can ffline power	$\begin{array}{c} \text{Burkey, 2.8A W} \\ \text{Burkey, 2.8A W} \\$		

* Drain current limited by maximum junction temperature.



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC I	PARAMETERS					
	Drain Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25°C	800			
BV _{DSS}	V _{DSS} Drain-Source Breakdown Voltage	I_D =250µA, V_{GS} =0V, T_J =150°C		900		V
BV _{DSS} /∆TJ	Breakdown Voltage Temperature Coefficient	I _D =250μΑ, V _{GS} =0V		0.78		V/°C
	DSS Zero Gate Voltage Drain Current	V _{DS} =800V, V _{GS} =0V			1	μΑ
DSS		V _{DS} =640V, T _J =125°C			10	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 30V$			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	3.3	4.2	4.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =1.5A		3.8	4.8	Ω
g _{FS}	Forward Transconductance	V _{DS} =40V, I _D =1.5A		2.5		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.77	1	V
ls	Maximum Body-Diode Continuous Current				2.8	Α
I _{SM}	Maximum Body-Diode Pulsed Current				9	Α
DYNAMI	C PARAMETERS					
C _{iss}	Input Capacitance			510		pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =25V, f=1MHz		39		pF
C _{rss}	Reverse Transfer Capacitance			3.7		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.9		Ω
SWITCHI	ING PARAMETERS					
Qg	Total Gate Charge	V _{GS} =10V, V _{DS} =640V, I _D =3A		10		nC
Q_{gs}	Gate Source Charge			2.6		nC
Q _{gd}	Gate Drain Charge			2.9		nC
t _{D(on)}	Turn-On DelayTime			21		ns
t _r	Turn-On Rise Time	V _{GS} =10V, V _{DS} =400V, I _D =3A,		25		ns
t _{D(off)}	Turn-Off DelayTime	$R_{G}=25\Omega$		34		ns
t _f	Turn-Off Fall Time			19		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =3A,dI/dt=100A/μs,V _{DS} =100V		344		ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =3A,dI/dt=100A/μs,V _{DS} =100V		2.2		μC

A. The value of R $_{_{\rm \theta JA}}$ is measured with the device in a still air environment with T $_{\rm A}$ =25 $^\circ\,$ C.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C, Ratings are based on low frequency and duty cycles to keep initial

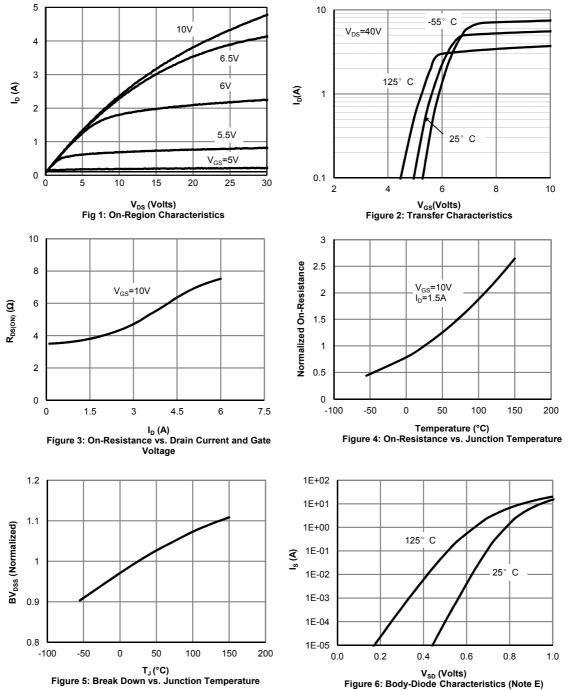
T_J =25° C.

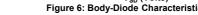
 $r_J = 25$ C. D. The R_{0JA} is the sum of the thermal impedance from junction to case R_{0JC} and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating. G. L=60mH, I_{AS}=2.2A, V_{DD}=150V, R_G=25Ω, Starting T_J=25° C

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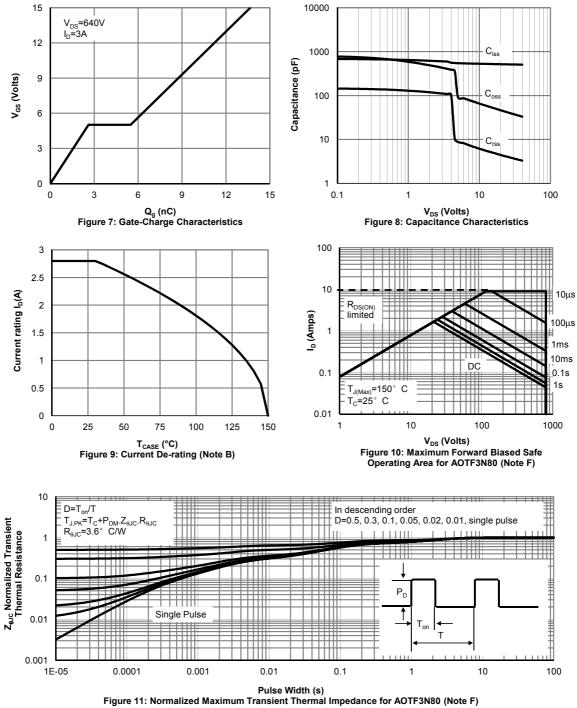
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





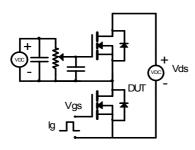


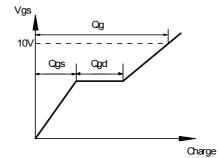
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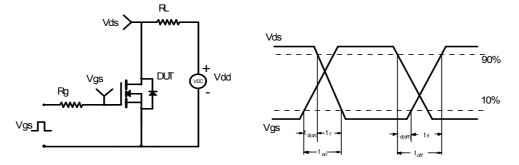


Gate Charge Test Circuit & Waveform

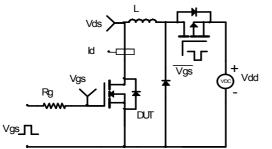


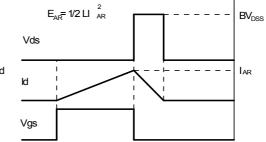


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

